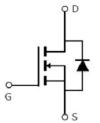


Main Product Characteristics:

V _{DSS}	600V
R _{DS} (on)	1.1Ω (typ.)
I _D	4A ①







TO-252

Marking and pin
Assignment

Schematic diagram

Features and Benefits:

Feathers:

- High dv/dt and avalanche capabilities
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance



Description:

The SSF4NS60D series MOSFETs is a new technology, which combines an innovative super junction technology and advance process. This new technology achieves low Rdson, energy saving, high reliability and uniformity, superior power density and space saving.

Absolute max Rating:

Symbol	Parameter	Max.	Units	
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V	4 ①		
I _D @ TC = 100°C	Continuous Drain Current, V _{GS} @ 10V	2.5 ①	Α	
I _{DM}	Pulsed Drain Current ②	12	ļ	
P _D @TC = 25°C	Power Dissipation ③	50	W	
	Linear Derating Factor	0.4	W/°C	
V _{DS}	Drain-Source Voltage	600	V	
V _{GS}	Gate-to-Source Voltage		V	
Eas	Single Pulse Avalanche Energy @ L=22.4mH		mJ	
I _{AR}	Avalanche Current @ L=22.4mH	2.2	А	
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C	



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-case ③		2.5	°C/W
$R_{\theta JA}$	Junction-to-ambient (t \leq 10s) \oplus	ı	75	°C/W

Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source breakdown voltage	600	_	_	V	$V = V_{GS} = 0V, I_D = 250\mu A$	
D			1.1	1.2	Ω	$V_{GS}=10V, I_{D}=2.8A$	
R _{DS(on)}	Static Drain-to-Source on-resistance	_	2.8	_	12	T _J = 125°C	
V	Cata threshold voltage	2	_	4	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
$V_{GS(th)}$	Gate threshold voltage	_	2.7	_	V	T _J = 125°C	
1	Drain to Source leakage current	_	_	1	^	$V_{DS} = 600V, V_{GS} = 0V$	
I _{DSS}	Drain-to-Source leakage current		_	50	μA	T _J = 125°C	
1	Cata to Source forward lookage	_	_	100	nA	V _{GS} =30V	
I_{GSS}	Gate-to-Source forward leakage	_	_	-100		V _{GS} = -30V	
Q_g	Total gate charge	_	8.3	_		$I_D = 4A$,	
Q_{gs}	Gate-to-Source charge	_	2.3	_	nC	V _{DS} =100V,	
Q_{gd}	Gate-to-Drain("Miller") charge	_	2.6	_		V _{GS} = 10V	
t _{d(on)}	Turn-on delay time	_	9.8	_			
t _r	Rise time	_	17.6	_		V _{GS} =10V, V _{DS} =380V,	
t _{d(off)}	Turn-Off delay time	_	19.0	_	ns	$R_{GEN}=18\Omega, I_D=4A$	
t _f	Fall time	_	15.3	_			
C _{iss}	Input capacitance	_	268	_	V _{GS} = 0V		
Coss	Output capacitance	_	222	_	pF	V _{DS} = 25V	
C _{rss}	Reverse transfer capacitance	_	4.62	_		f = 1MHz	

Source-Drain Ratings and Characteristics

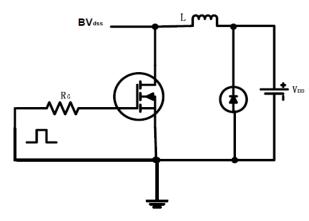
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current		_	4 ①	А	MOSFET symbol
Is	(Body Diode)	_				showing the
I _{SM}	Pulsed Source Current			40	٨	integral reverse
	(Body Diode)	_	_	12	Α	p-n junction diode.
V _{SD}	Diode Forward Voltage	_	0.88	1.2	V	I _S =2.8A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	180	_	nS	$T_J = 25^{\circ}C, I_F = I_S,$
Q _{rr}	Reverse Recovery Charge	_	1304	_	nC	di/dt = 100A/µs

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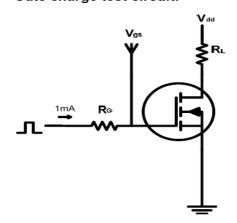


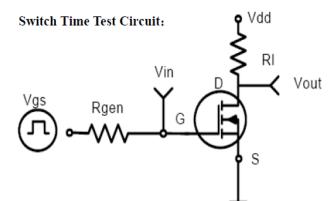
Test circuits and Waveforms

EAS test circuits:

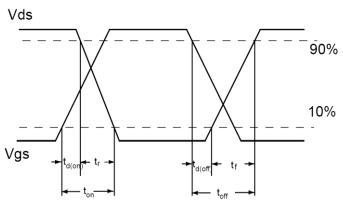


Gate charge test circuit:





Switch Waveforms:

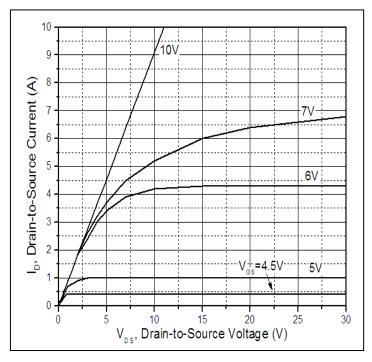


Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- 4The value of $R_{\texttt{6JA}}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C



Typical electrical and thermal characteristics



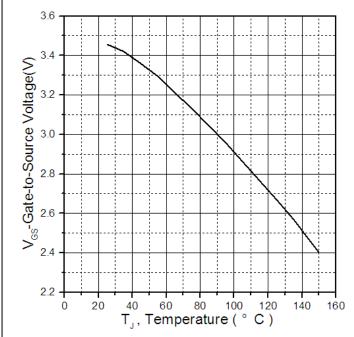
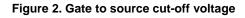


Figure 1: Typical Output Characteristics



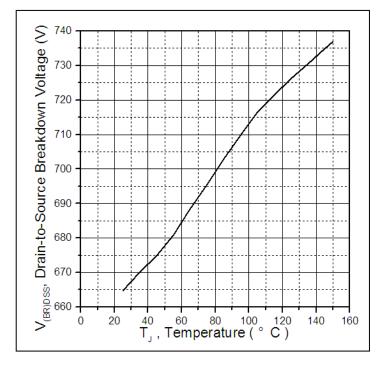


Figure 3. Drain-to-Source Breakdown Voltage Vs.

Case Temperature

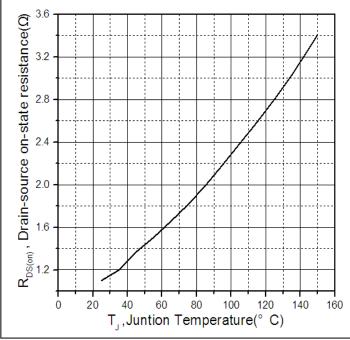


Figure 4: Normalized On-Resistance Vs. Case Temperature



Typical electrical and thermal characteristics

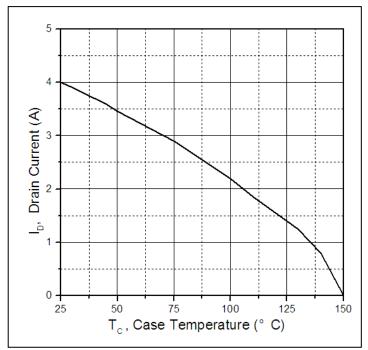


Figure 5. Maximum Drain Current Vs. Case
Temperature

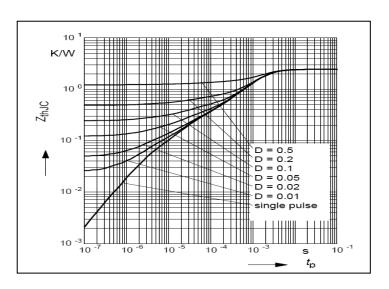


Figure 7. Maximum Effective Transient Thermal Impedance
Junction-to-Case

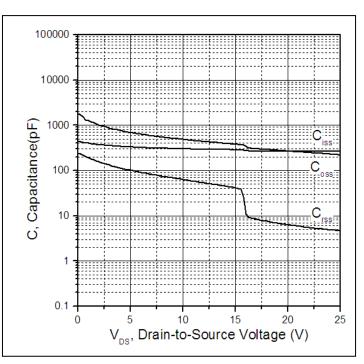
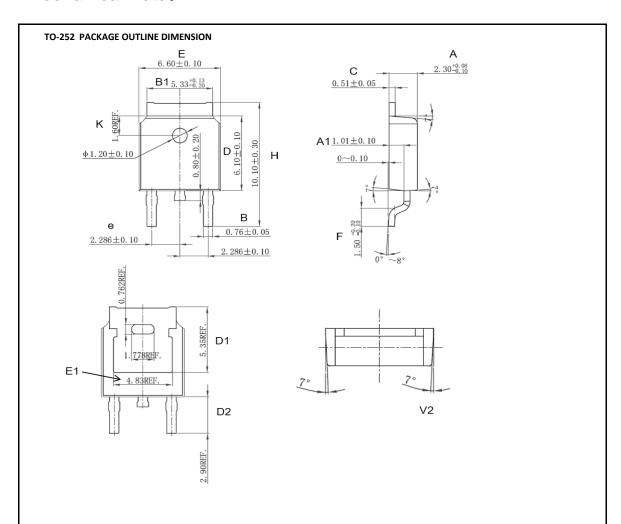


Figure 6. Typical Capacitance Vs. Drain-to-Source Voltage



Mechanical Data:



Cymhal	Dimension In Millimeters			Dimension In Inches		
Symbol	Min	Nom	Max	Min	Nom	Max
Α	2.200	2.300	2.380	0.087	0.091	0.094
A1	0.910	1.010	1.110	0.036	0.040	0.044
В	0.710	0.760	0.810	0.028	0.030	0.032
B1	5.130	5.330	5.460	0.202	0.210	0.215
С	0.460	0.510	0.560	0.018	0.020	0.022
D	6.000	6.100	6.200	0.236	0.240	0.244
D1		5.350 (REF)		0.211 (REF)		
D2		2.900 (REF)		0.114 (REF)		
Е	6.500	6.600	6.700	0.256	0.260	0.264
E1		4.83 (REF)	•	0.190 (REF)		
е	2.186	2.286	2.386	0.086	0.090	0.094
Н	9.800	10.100	10.400	0.386	0.398	0.409
F	1.400	1.500	1.700	0.055	0.059	0.067
K	1.600 (REF)				0.063 (REF)	
V2	8 ⁰ (REF)				8 ⁰ (REF)	



Ordering and Marking Information

Device Marking: SSF4NS60D

Package (Available)
TO-252(DPAK)
Operating Temperature Range
C: -55 to 150 °C

Devices per Unit

Option1:

Package Type	Units/Tape	Tapes/Inner Box	Units/Inner Box	Boxes/Carton	Units/Carton Box
				Box	
TO-252	2500	2	5000	7	35000

Option2:

Package Type	Units/Tape	Tapes/Inner Box	Units/Inner Box		Units/Carton Box
				Box	
TO-252	2500	1	2500	10	25000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			

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